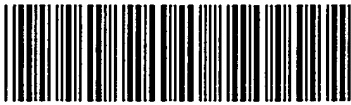


Search Notes

Application/Control No.

10/763,724

Examiner

Yonel Beaulieu

Applicant(s)/Patent under
Reexamination

KRULL ET AL.

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR